

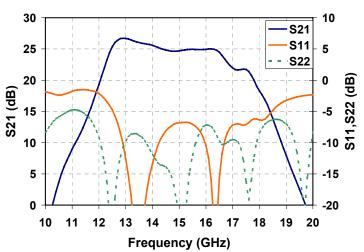
Ku Band 2 Watt Packaged Amplifier

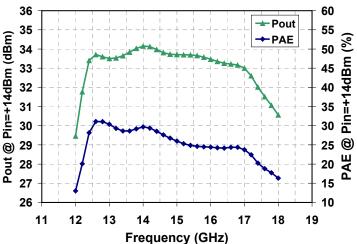
TGA2510-EPU-SG



Preliminary Measured Performance

Bias Conditions: Vd=7.5V Id=650mA





Key Features and Performance

- 33.5 dBm Midband Psat
- 25 dB Nominal Gain
- 7 dB Typical Input Return Loss
- 10 dB Typical Output Return Loss
- 12.5 17 GHz Frequency Range
- Directional Power Detector with Reference
- 0.25µm pHEMT 3MI Technology
- Bias Conditions: 7.5V, 650mA
- Package Dimensions:
 9.4 x 6.4 x 1.8 mm
 (0.370 x 0.250 x 0.071 inches)

Primary Applications

- VSAT
- Point to Point



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TABLE I **MAXIMUM RATINGS**

Symbol	Parameter	Value	Notes
V _D	Drain Voltage	8 V	<u>1</u> / <u>2</u> /
V_{G}	Gate Voltage Range	-5V to 0V	<u>1</u> /
I _D	Drain Supply Current (Quiescent)	1300 mA	<u>1</u> / <u>2</u> /
I _G	Gate Supply Current	18 mA	<u>1</u> /
P _{IN}	Input Continuous Wave Power	24 dBm	<u>1</u> / <u>2</u> /
P_{D}	Power Dissipation	6.15 W	<u>1</u> / <u>2</u> / <u>3</u> /
T _{CH}	Operating Channel Temperature	150 °C	<u>4</u> /
T _M	Mounting Temperature (30 Seconds)	320 °C	
T _{STG}	Storage Temperature	-65 to 150 °C	

- 1/ These ratings represent the maximum operable values for this device
- <u>2</u>/ Combinations of supply voltage, supply current, input power, and output power shall not exceed P_D at a package base temperature of 70°C
- When operated at this bias condition with a baseplate temperature of 70°C, the 3/ MTTF is reduced to 1.0E+6 hours
- Junction operating temperature will directly affect the device median time to failure (MTTF). For maximum life, it is recommended that junction temperatures be maintained at the lowest possible levels.

TABLE II THERMAL INFORMATION

Parameter	Test Conditions	T _{CH} (°C)	R _{⊕JC} (°C/W)	MTTF (hrs)
R _{⊝JC} Thermal Resistance (Channel to Backside of Package)	$V_D = 7.5V$ $I_D = 650$ mA $P_{DISS} = 4.88$ W $T_{BASE} = 70$ °C	132.3	12.8	4.8E+6



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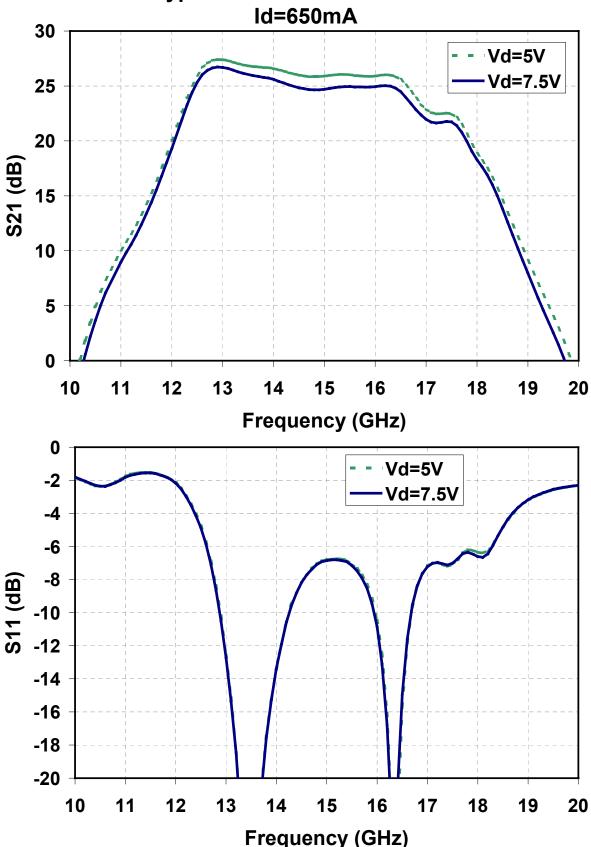
TABLE III RF CHARACTERIZATION TABLE ($T_A = 25$ °C, Nominal) (Vd = 7.5V, Id = 650mA ± 5 %)

Symbol	Parameter	Test Conditions	Тур	Units	Notes
Gain	Small Signal Gain	F = 12.5 – 16 GHz	25	dB	
IRL	Input Return Loss	F = 12.5 – 16 GHz	7	dB	
ORL	Output Return Loss	F = 12.5 – 16 GHz	10	dB	
PWR	Output Power @ Pin = +14dBm	F = 12.5 – 16 GHz	33.5	dBm	
PAE	Power Added Efficiency @ Pin = +14dBm	F = 12.5 – 16 GHz	29	%	

Note: Table III Lists the RF Characteristics of typical devices as determined by fixtured measurements.

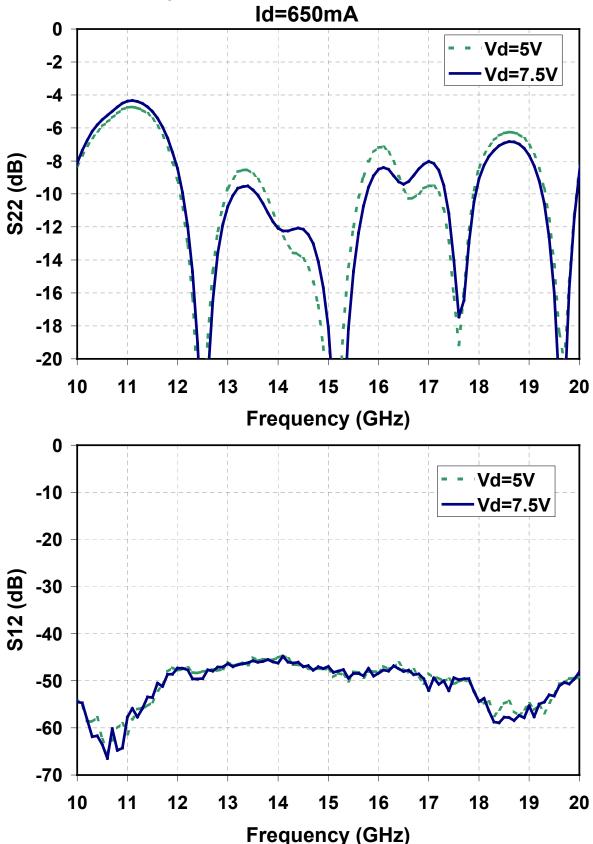


Typical Fixtured Performance TGA2510-EPU-SG



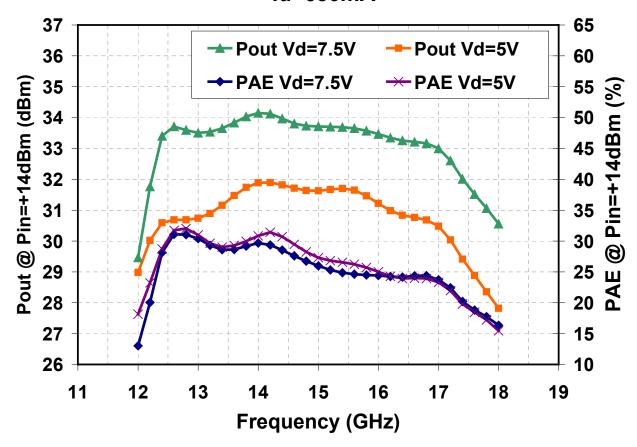






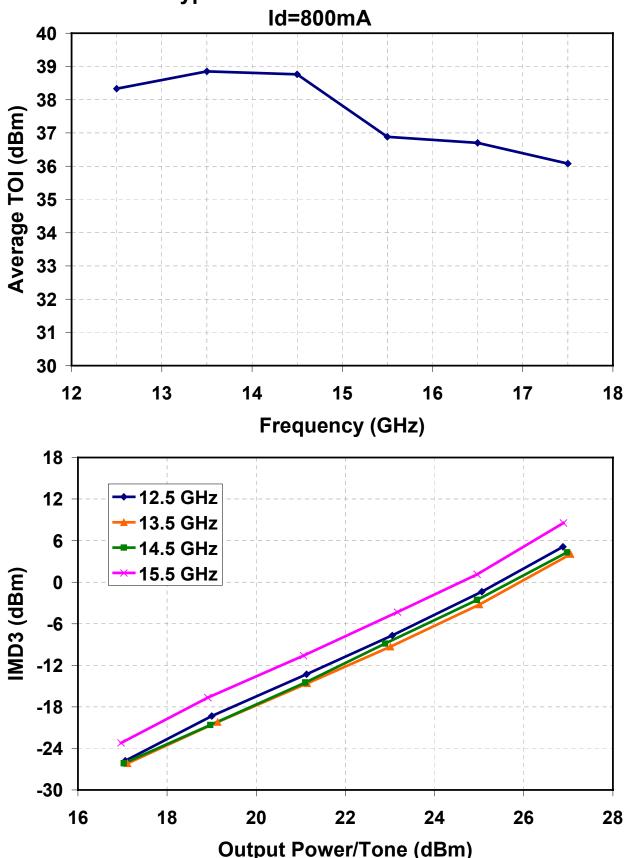


Typical Fixtured Performance Id=650mA



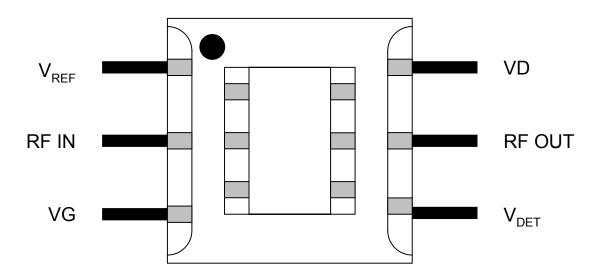




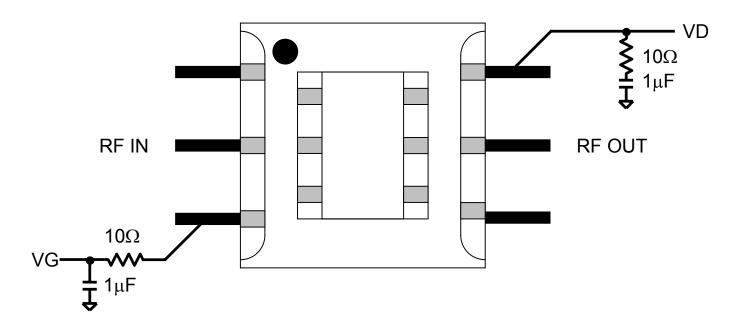




Package Pinout Diagram



Package Assembly Diagram



GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

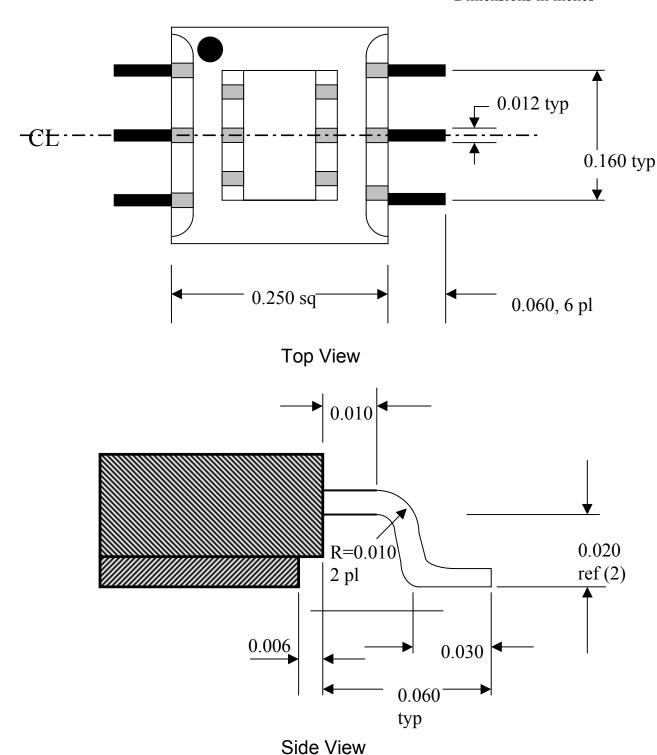


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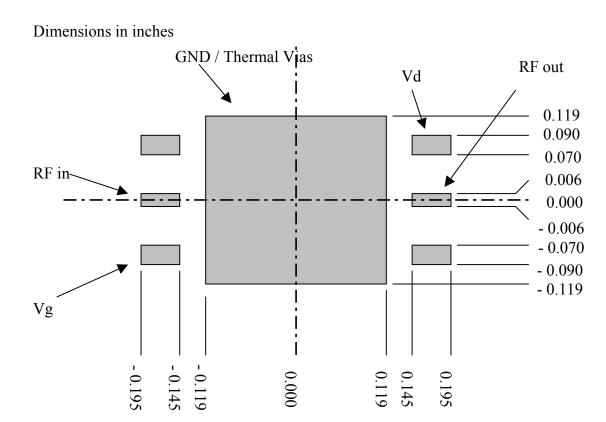
Mechanical Drawing

Dimensions in inches





Recommended PWB Land Pattern





Power Detector

